

Notice of References Cited	Application/Control No. 10/705,396	Applicant(s)/Patent Under Reexamination ASOKAN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0065785 A1	05-2002	Tsuda, Yoshiyuki	705/67
	B	US-2003/0119501 A1	06-2003	Kim, Young-Hae	455/433
	C	US-2003/0092425 A1	05-2003	Okazaki et al.	455/411
	D	US-2002/0145561 A1	10-2002	Sandhu et al.	342/357.09
	E	US-6,769,000 B1	07-2004	Akhtar et al.	707/103R
	F	US-2004/0181692 A1	09-2004	Wild et al.	713/201
	G	US-2002/0118674 A1	08-2002	Faccin et al.	370/352
	H	US-2003/0039361 A1	02-2003	Hawkes et al.	380/278
	I	US-2003/0090998 A1	05-2003	Lee et al.	370/229
	J	US-2003/0091030 A1	05-2003	Yegin et al.	370/352
	K	US-2004/0064741 A1	04-2004	Haverinen et al.	713/202
	L	US-2002/0037708	03-2002	McCann et al.	455/411
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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